

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of: Sidney M. Baker, et al.

Serial No.: 09/765,714

Examiner: Vanel Frenel

Filed: January 18, 2001

Group Art Unit: 3626

For: SYSTEM AND METHOD FOR THE AUTOMATED PRESENTATION OF  
SYSTEM DATA TO, AND INTERACTION WITH, A COMPUTER  
MAINTAINED DATABASE

Mail Stop RCE  
Commissioner for Patents  
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Signature:

  
Aaron S. HalevaINFORMATION DISCLOSURE STATEMENT

Sir:

Applicants respectfully submit this Information Disclosure Statement pursuant to 37 C.F.R. §§ 1.97 and 1.98 in order to comply with the duty of disclosure under 37 C.F.R. § 1.56. These references are listed on the attached modified PTO Form No. 1449. A copy of the listed references are also enclosed.

Applicants respectfully request that the information be expressly considered during the prosecution of this application and that the references be made of record therein and appear among the "References Cited" on any patent to issue therefrom. Applicants further request that a copy of the PTO Form No. 1449, appropriately initialed by the Examiner, be returned to Applicants' attorney.

Although no fee is believed to be due in connection with the filing of this Information Disclosure Statement, the Director is hereby authorized to charge any fee(s) deemed necessary to Deposit Account No. 50-0540.

Respectfully submitted,



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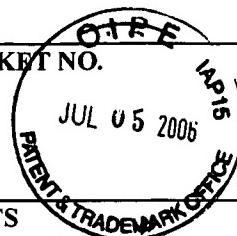
Date: June 29, 2006

Based on Form PTO-1449  
(3/90)

ATTY. DOCKET NO.  
59376/0002

SERIAL NO.  
09/765,714

**LIST OF REFERENCES CITED BY APPLICANT**  
(Use several sheets if necessary)



APPLICANTS

Sidney Baker, et al.

FILING DATE

January 18, 2001

GROUP ART UNIT

3626

**U.S. PATENT DOCUMENTS**

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB-CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						

**FOREIGN PATENT DOCUMENTS**

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION
	BA						
	BB						
	BC						
	BD						
	BE						
	BF						
	BG						

**OTHER PUBLICATIONS** (Including Author, Title, Date, Pertinent Pages, Etc.)

/VF/	CA	David K.Y. Chiu and A.K.C. Wong, "An Event-Covering Approach for Cluster Analysis of Discrete-Valued Data with Application to Medical Diagnosis" The First Conference on Artificial Intelligence Applications, IEEE Computer Society (1984).
/VF/	CC	Dario Lucarella, "A document retrieval system based on nearest neighbour searching" Journal of Information Science 14 (1988), pp. 25-33.
/VF/	CD	W. John Wilbur, "Retrieval Testing by the Comparison of Statistically Independent Retrieval Methods" Journal of the American Society for Information Science 43(5) (1992), pp. 358-370.
/VF/	CE	Li.M. de Bruijn, A. Hasman, J.W. Arends, "Automatic SNOMED classification-a corpus-based method" Computer Methods and Programs in Biomedicine 54 (1997), pp. 115-122.
/VF/	CG	Leah S. Larkey and W. Bruce Croft, "Combining Classifiers in Text Categorization" Proceedings of the 19 <sup>th</sup> Annual International ACM SIGIR Conference on Research and Development in Information Retrieval (1996), pp. 289-297.
/VF/	CH	Jochen Bernauer, M.D., "A Controlled Vocabulary Framework for Report Generation in Bone-Scintigraphy" Fourteenth Annual Symposium on Computer Applications in Medical Care (1990), pp. 195-199.
	CI	

<b>EXAMINER</b>	/Vanel Frenel/	<b>DATE CONSIDERED</b>	02/18/2010
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\* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.